Application/Control No. O9/575,055 Reexamination LIU ET AL. Examiner Chuong A Luu Applicant(s)/Patent Under Reexamination LIU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-6313492 B1	11-2001	Hakey et al.	257	296
	В	US-6303391 B1	10-2001	Hintermaier et al.	438	. 3
	С	US-6291865 B1	09-2001	Lee	257	410
	D	US-5928960	07-1999	Greco et al.	438	692
	Е	US-				
	F	US-		·		
	G	US-				
	Н	US-				
	ı	US-				
	J	US-				
	K	US-				
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	S				<u> </u>		
	Т				S		

NON-PATENT DOCUMENTS

NON-PATENT DOCUMENTS			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U	AI A	
	V	BLE	
	w	COP	
	x	~	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.